

Best Available Copy

370	401 228 245 244	9/21/04 9/21/04 9/21/04 9/21/04	R.P.G. R.P.G. R.P.G. R.P.G.
370	225 242 243	9/21/04 9/21/04 9/21/04	R.P.G. R.P.G. R.P.G.
Class	Sub.	Date	Exmr.
455	408 424 226.1	11/6/03 ↓	Amr ↓
370	352 358 352 236.1 5409	11/6/03 ↓	Amr ↓
702	170 122 187 120	11/6/03 ↓	Amr ↓
Updated search		9/21/04	R.P.G.
Y55	67.11 422 423 414.1	9/21/04 9/21/04 9/21/04 9/21/04	R.P.G. R.P.G. R.P.G. R.P.G.
714	2 3 4 15 10 11 12 23 25 47	9/21/04 9/21/04 9/21/04 9/21/04 9/21/04 9/21/04 9/21/04 9/21/04 9/21/04 9/21/04	R.P.G. R.P.G. R.P.G. R.P.G. R.P.G. R.P.G. R.P.G. R.P.G. R.P.G. R.P.G.
370	218 219 220 221 216 217	9/21/04 9/21/04 9/21/04 9/21/04 9/21/04 9/21/04	R.P.G. R.P.G. R.P.G. R.P.G. R.P.G. R.P.G.
Updated search		10/1/04	R.P.G.
INTERFERENCE SEARCHED			
Class	Sub.	Date	Exmr.

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
electron keyboard search was used	Date	Exmr.
	11/6/03	Amr
EST Image and keyword search in UTPAT, W-PATUB, END, JPD, ORIENT, and JSM-TDB	9/21/04	R.P.G.
Inventor names and Assignee search in PAM EXPD and CAST	9/21/04	R.P.G.
WIPD Database http://patgate.wip.int	9/21/04	R.P.G.
END Database http://exp.patgate.wip.int	9/21/04	R.P.G.
IEEE Explore http://ieeexplore.ieee.org/Explore/DynWeb.jsp	9/21/04	R.P.G.
updated search	2-26-7	Amr